

Search Notes

Application/Control No.

10/617,492

Examiner

Sherali Ishrat

Applicant(s)/Patent under
Reexamination

YEH, CHIA-YOW

Art Unit

2624

SEARCHED

| Class | Subclass | Date | Examiner |
|-------|----------|-----------|----------|
| 382 | 232-253 | 5/20/2007 | IS |
| 375 | 240- | 5/20/2007 | IS |
| | 240.27 | | |
| 358 | 426.01- | 5/20/2007 | IS |
| | 426.16 | | |
| 341 | 59, 65 | 5/20/2007 | IS |
| | 67, 104 | | |
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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

| | DATE | EXMR |
|------------|-----------|------|
| IEEE, EAST | 5/20/2007 | IS |
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INTERFERENCE SEARCHED

| Class | Subclass | Date | Examiner |
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